



### SDRS7045 Series, Shielded SMD Power Inductors





### ▶特征:

- 高饱和电流, 低直流电阻
- 闭合磁路设计减少漏磁
- 自动贴装的高精度尺寸
- 多种封装尺寸和宽电感范围
- 符合 RoHS,无卤和 REACH

#### ▶用途:

- 薄型 TV、液晶显示器、AV 设备、游戏设备
- 其他各种电子仪器
- DC/DC 转换器等

#### ◆环境:

• 工作温度: -40℃ 至+125℃ (包括线圈自身温升)

### ◆试验设备:

- 电感值:HP4284A, HP4285A 或同等仪器
- 电流:HP4284+42841A 或同等仪器
- 直流电阻: Chroma 16502 或同等仪器

# ◆产品型号:

**SDRS** 

70<u>45</u> 2

100 3

类型 Type 闭磁路贴片电感 **SDRS** Shielded SMD

Power Inductors

External Dimensions (L×W×H) (mm) 7.0×7.0×4.5 7045

外形尺寸(L×W×H) (mm)

(5)

(5)

包装 Packing				
B 散装Bulk Package				
	编带Tape & Reel			

### Features:

- High saturation current, low DCR
- Close magnetic circuit design reduce leakage
- Hig hlyaccurate dimensions for automatic mounting
- Various package size and wide inductance range
- RoHS, Halogen Free and REACH Compliance

### Applications:

- Thin-screen TVs, LCDs, AV equipment, Gaming equipment
- Other electrical devices
- DC/DC converters, etc

#### **Environmental Data:**

 Operating Temperature: -40 ℃ to +125 ℃ (Including coils self-temperature rise)

### **Test Equipment:**

- L:HP4284A or HP4285A LCR meter or equivalent
- Isat & Irms: HP4284+42841A or equivalent
- DCR:Chroma 16502 or equivalent

### **Product Identification:**

Inductance 10 uH

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公差 Inductance Tolerance

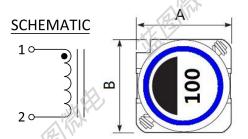
J:±5%,K: ±10%, L: ±15% M: ±20%,P: ±25%, N: ±30%

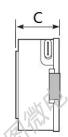


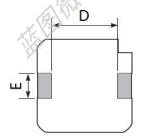


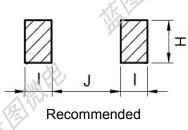
## ◆外观尺寸:

# Shape and Dimensions (dimensions are in mm):









Land Pattern

Dort No.				ITEM				
Part No	A	В	С	D	) E	Н	ı	J <sub>.uk</sub>
SDRS7045	7.0±0.2	7.0±0.2	4.5±0.3	4.0	2.0	2.2	2.0	4.0

### ◆规格特性:

### Specifications:

• SDRS7045 Series Electrical Characteristics (Electrical specifications at 25℃)

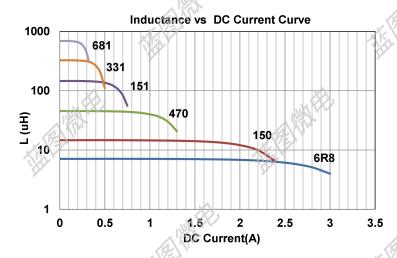
	ı	nductance		DCR	Saturation Current	Temperature Rise Current	
Part No	L(μH) '@0A	Tole	Test Freq	(Ω) ±20%	(A) Max	(A) Max	
SDRS7045-3R3N	3.3	±30%	100KHz	0.020	2.50	2.30	
SDRS7045-4R7N	4.7	±30%	100KHz	0.030	2.00	2,10	
SDRS7045-6R8N	6.8	±30%	100KHz	0.039	1.70	174	
SDRS7045-100N	10	±30%	100KHz	0.036	1.30	1.78	
SDRS7045-150N	15	±30%	100KHz	0.052	1.10	1.53	
SDRS7045-220N	22	±30%	100KHz	0.061	0.90	1.34	
SDRS7045-330N	33	±30%	100KHz	0.096	0.82	1.09	
SDRS7045-470N	47	±30%	100KHz	0.125	0.75	0.92	
SDRS7045-680N	68	±30%	100KHz	0.175	0.60	0.77	
SDRS7045-101N	100	±30%	100KHz	0.250	0.50	0.65	
SDRS7045-151N	150	±30%	100KHz	0.340	0.40	0.55	
SDRS7045-221M	220	±20%	100KHz	0.520	0.33	0.45	
SDRS7045-331M	330	±20%	100KHz	0.740	0.25	0.37	
SDRS7045-471M	470	±20%	100KHz	1.050	0.22	0.31	
SDRS7045-681M	680	±20%	100KHz	1.480	0.20	0.27	
SDRS7045-102M	1000	±20%	100KHz	2.280	0.14	0.25	

- •Saturation Current: DC current at which inductance drops 10%from its value without current.
- ●Temperature Rise Current: the actual value of DC current when the temperature rise isΔT 40°C (Ta=25°C).
- Rated DC Current: The less value which is Isat or Irms.
- Special remind:Circuit design, component, PCB trace size and thickness, airflow and other cooling provisions all affect the part temperature. Part temperature should be verified in the end application.



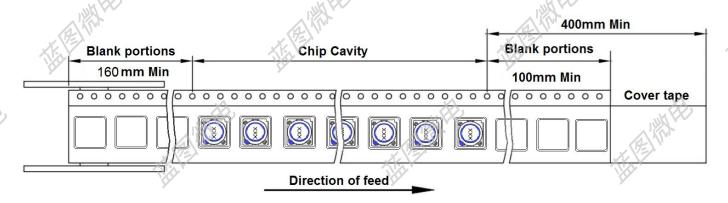


Saturation current

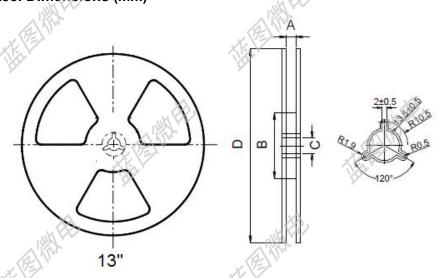


◆产品包装: Packaging:

• Tape and Reel Specifications: (Dimensions are in mm)



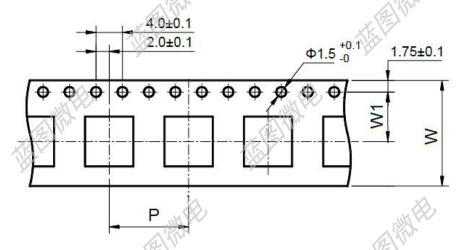
• Reel Dimensions (mm)





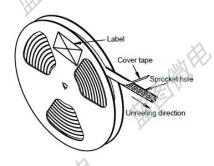


# ●Tape Dimension (mm)

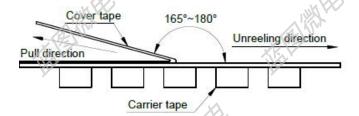


Dort No.	Тар	e Dimen	sion		Reel Din	nensions		REEL	Inside	Outside
Part No.	W	Р	W1	Α	В	С	D	(PCS)	Box(PCS)	Carton(PCS)
SDRS7045	16	12	7.5	16.4	60	13	330	1000	3000	12,000

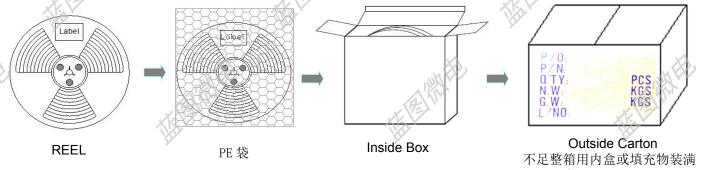
## • Cover tape peel off condition



- a) Cover tape peel force shall be 10 to 120g
- b) Noodle strip peeling angle165° to 180°



### Packing quantity







# ◆可靠性测试:

# Reliability Testing:

Items	Requirements	Test Methods and Remarks
Terminal Strength Reference docu ments: GB/T 2423 60-2008 端子強度(SMT)	1. Pulling test:  Define: A: sectional area of terminal  A ≤ 8mm2 force ≥ 5N time:30sec  8mm2 <a 10n="" 10sec="" 2.solder="" 20mm2="" 20mm2<a="" 20n="" 3.meet="" above="" any="" force="" loose="" paste="" requirements="" td="" terminal<="" the="" thickness:0.12mm="" time:="" without="" ≤="" ≥=""><td>Solder the inductor to the testing jig using leadfree solder. Then apply a force in the Keep time: 10±1s Speed: 1.0mm/s.</td></a>	Solder the inductor to the testing jig using leadfree solder. Then apply a force in the Keep time: 10±1s Speed: 1.0mm/s.
erminal Strength Reference docu ments: GB/T 2423.60-2008 端子強度(DIP)	1.Terminal diameter(d) mm 0.35 < d < 0.50 Applied force:5N Duration: 10sec2.Terminal diameter(d) mm0.50 < d < 0.80 Applied force:10N Duration: 10sec3.Terminal diameter(d) mm0.80 < d < 1.25 Applied force:20N Duration: 10sec4.Terminal diameter(d) mmD > 1.25 Applied force:40N Duration: 10sec5.Meet the above requirements without any loose terminal.	Pull Force:the force shall be applied gradually to the terminal and thenmaintained for 10 seconds.  F  Pulling test
Resistance to Flexure JIS C 5321:1997 抗弯曲性试验	1.No visible mechanical damage.	1.Solder the inductor to the test jig (glass epoxy board 2.shown in Using a leadfree solder. Then apply a force in the direction shown 3.Flexure: 2mm. 4.Pressurizing Speed: 0.5mm/sec. 5.Keep time: 30 sec.
Dropping Reference documents: GB/T 2423.7-2018 落下試驗	1.No case deformation or change inappearance.     2.No short and no open.	1.Drop the packaged products from 1m high in 1 angle, 3 ridges and 6surfaces, twice in each direction.
Solderability Reference documents: GB/T 2423.28-2005 可焊性试验	3. Terminals must have 95% minimum solder	<ol> <li>Solder temperture:240±2°C</li> <li>Duration: 3 sec.</li> <li>Solder: Sn/3.0Ag/0.5Cu.</li> <li>Flux: 25% Resin and 75% ethanol in weight</li> </ol>





Items	Requirements	Test Methods and Remarks
Vibration Reference documents: GB/T 2423.10-2019 振動試验	1.No visible mechanical damage.  2. Inductance change: Within ±10%.  3.Q factor change: Within ±20%.  Cu pad Solder mask  Glass Epoxy Board	1.Solder the inductor to the testing jig (glass epoxy boardshown in ) using leadfree solder.  2.The inductor shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varieduniformly between the approximate limits of 10 and 55 Hz.  3.The frequency range from 10 to 55 Hz and return to 10 Hz shallbe traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3mutually perpendicular directions(total of 6 hours).
推圖機構	遊遊	Freq 55Hz 10Hz 0 1Min Time
y .	1.No visible mechanical damage.	1.Start at ( 85~125℃) for T time, rush to
Thermal Shock	<ol> <li>Inductance change: Within ±10%.(Mn-Zn: Within ≤30%)</li> <li>Q factor change: Within ±20%.</li> </ol>	(-55~40°C) for T time as one cycle, go through100 cycles.  2.Transforming interval: Max. 20 sec.
Reference documents:	ign ign	3.Tested cycle: 100 cycles.     4.The chip shall be stabilized at normal condition.
GB/T 2423.22-2012 Method Na 冷热冲击试验	推起機構	for 1~2 hours  125 °C/85 °C  Ambient  Temperature  -55 °C/-40 °C  20sec. (max.)
	in the	white
	1.No visible mechanical damage.	1.Temperature:M(-55~-40±2℃)
	2. Inductance change: Within ±10%.(Mn-Zn:	2.Duration: 96±2 hours
	Within ≦30%)	3.The chip shall be stabilized at normal condition for
Reference documents: GB/T 2423.1-2008 Method Ab	3.Q factor change: Within ±20%.	1~2 hoursbefore measuring.
低温储存试验		0 96H Test 97H 98H Time  M°C Temp Low temperature





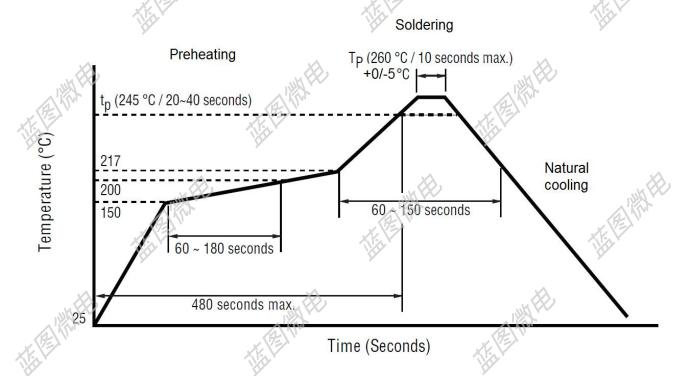
Items	Requirements	Test Methods and Remarks
	1.No visible mechanical damage.	1.Temperature:N(125~85±2℃).
High temperature	2. Inductance change: Within ±10%.(Mn-Zn:	2.Duration: 96±2 hours
Storage	Within ≦30%)	3. The chip shall be stabilized at normal condition
Reference documents:	3.Q factor change: Within ±20%.	for 1~2 hoursbefore measuring.
GB/T 2423.2-2008	E Thi	High temperature
Method Bb	K. K.	XII.
高温储存试验	***	Room Temp
	<u> </u>	0 96H 97H 98H Time
	1.No visible mechanical damage.	1.Temperature: 60±2°C
	2. Inductance change: Within ±10%.(Mn-Zn:	
Damp Heat	Within ≤ 30% )	3.Duration: 96±2 hours.
(Steady States)	3.Q factor change: Within ±20%.	4.The chip shall be stabilized at normal condition
Reference documents:	× ×	for 1~2 hoursbefore measuring.
GB/T 2423.3-2016	July FEE	Temp
恒定湿热试验	E TW	93%RH High temperature
		Room Conditions
<i>y</i>	Y	Test 0 96H 97H 98H Time
llast and war as of	1.No significant defects in appearance.	90H 97H 90H 111116
Heat endurance of Reflow soldering	2. △ L/L ≤ 10% (Mn-Zn: △ L/L ≤ 30%)	1 Refer to the above reflow curve and go through the reflow for twice.
Reference documents:	3. △ Q/Q ≤ 30% (SMD series only)	2.The peak temperature : 260+0/-5°C
GJB 360B-2009	4. △ DCR/DCR ≦ 10%	
回流焊耐热性试验		·
<i>X</i> 3.	No case deformation or change in	To dip parts into IPA solvent for 5±0.5Min,then
Resistance to solvent	appearance or obliteration of marking	drying them at room temp for 5Min,at last ,to
test	A PENT	brushing making 10 times.
Reference documents: IEC 68-2-45:1993	THE	THE P
NEC 08-2-45:1993 耐溶剂性试验		·
<b>则役剂性风</b> 翅	<i>X</i> 3.	<i>x</i> . <i>x</i> .
Overload test	1.During the test no smoke, no peculiar,	
Reference documents:	smell, no fire	Apply twice as rated current for 5 minutes.
	2. The characteristic is normal after test	ripply twice do rated current for a minutes.
过负荷试验		
voltage resistance test	1.During the test no breakdown	
Reference documents:	2.The characteristic is normal after test	For parts with two coils
MIL-STD-202G Method	A PENT	2. DC1000V, Current: 1mA, Time: 1Min.
301	This	3. Refer to catalogue of specific products
绝缘耐压测试	*	





### ◆推荐回流焊温度曲线

### Recommended reflow soldering curve:



The recommended reflow conditions as above graph, is set according to our soldering equipment. DUE to various manufactures may have different reflow soldering equipment, products, process conditions, set methods. And so on, when setting the reflow conditions, Please adjust and confirm according to users' environment/equipment.





### 使用注意事项

# REMINDERS FOR USING THESE PRODUCTS



● 保存时间为12 个月以内,保存条件(温度5~40°C以下、湿度35 ~ 66%RH 以下),需充分注意 若超过保存时间,端子电极的可焊性将可能老化。

The storage period is within 12 months. Be sure to follow the storage conditions (temperature: 5~40°C, humidity: 35 to 65% RH or less). If the storage period elapses, the soldering of the terminal electrodes may deteriorate.

- 请勿在气体腐蚀环境(盐、酸、碱等)下使用和保存。
  - Do not use or store in locations where there are conditions such as gas corrosion (salt, acid, alkali, etc.).
- 手上的油脂会导致可焊性降低,应避免用手直接接触端子。
   Don't touch electrodes directly with bare hands as oil secretions may inhibit soldering Always ensure optimum conditions for soldering。
- 请小心轻拿轻放,避免由于产品的跌落或取出不当而导致的损坏。
  Please always handle products carefully to prevent any damage caused bydropping down or inappropriate removing。
- 端子过度弯曲会导致断线,请不要过度弯曲端子。
   Don't bend the terminals with excessive stress in case of any wire fracture。
- 不要清洗产品,如需要清洗时请联系我司。
   Don't rinse coils by yourself and please contact SXN if necessary。
- 请勿将本产品靠近磁铁或带有磁力的物体 Don't expose the products to magnets or magnetic fields
- 在实施焊接前,请务必进行预热。预热温度与焊接温度及芯片温度的温度差要在150°C 以内。 Before soldering, be sure to preheat components. The preheating temperature should be set so that the
- 安装后的焊接修正应在规格书规定的条件范围内。若加热过度可能导致短路、性能降低、寿命减少。 Soldering corrections after mounting should be within the range of the conditions determined in the specifications. If overheated, a short circuit, performance deterioration, or lifespan shortening may occur.

temperature difference between the solder temperature and chip temperature does not exceed 150°C.

- 装置会因通电而自我发热(温度上升),因此在热设计方面需留有充分余地。
   Self heating (temperature increase) occurs when the power is turned ON, so the tolerance should be sufficient for the set thermal design.
- 非磁屏蔽型在基板设计时需注意配置线圈,受到电磁干扰可能会导致误动作。

  Carefully lay out the coil for the circuit board design of the non-magnetic shield type. A malfunction may occur due to magnetic interference.